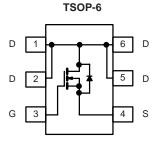


AM3444N-T1-PF-VB Datasheet N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ.)			
30	0.023 at V _{GS} = 10 V	6	4.2 nC			
30	0.027 at V _{GS} = 4.5 V	6	4.2 110			





FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- Trench Power MOSFET
- Low On-Resistance
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

• DC/DC Converters, High Speed Switching

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
Parameter		Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30	V		
Gate-Source Voltage		V _{GS}	± 20	V		
	T _C = 25 °C		6 ^e			
Continuous Drain Current ($T_1 = 150 \ ^{\circ}C$)	T _C = 70 °C		6 ^e	l		
Continuous Drain Current $(1) = 150$ C)	T _A = 25 °C	I _D	5.5 ^{b, c}	1		
	T _A = 70 °C		4.4 ^{b, c}	A		
Pulsed Drain Current (t = 300 µs)		I _{DM}	25	1		
Continuous Source-Drain Diode Current	T _C = 25 °C	L.	2.1	-		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	1.1 ^{b, c}			
	T _C = 25 °C		2.5	W		
Maximum Power Dissipation	T _C = 70 °C	P _D	1.6			
	T _A = 25 °C	۲D	1.3 ^{b, c}	vv		
	T _A = 70 °C		0.8 ^{b, c}	1		
Operating Junction and Storage Temperature	e Range	T _J , T _{stg}	- 55 to 150	℃		
Soldering Recommendations (Peak Tempera	ature)		260			

THERMAL RESISTANCE RATINGS Parameter Symbol Typical Maximum Unit Maximum Junction-to-Ambient^{b, d} t ≤ 5 s R_{thJA} 75 100 °C/W Maximum Junction-to-Foot (Drain) Steady State 40 50 R_{thJF}

Notes:

a. Based on $T_C = 25$ °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 166 °C/W.

e. Package limited.

•		erwise noted)	Min	Tree	Max	l lmit
Parameter Static	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$		00	30		- mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 4.8		
Gate-Source Threshold Voltage		V _{DS} = V _{GS} , I _D = 250 μA	0.5	- 4.0	1.5	V
Ŭ	V _{GS(th)}	$V_{DS} = V_{GS}$, $P_{DS} = 200 \mu R$ $V_{DS} = 0 V, V_{GS} = \pm 20 V$	0.5			
Gate-Source Leakage	I _{GSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 70 \text{ °C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 10 \text{ V}$	20		10	A
	·D(011)	$V_{GS} = 10 \text{ V}, I_D = 5.5 \text{ A}$	20	0.023		A
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 5 \text{ A}$		0.023		Ω
Forward Transconductance ^a	g _{fs}	$V_{\rm DS} = 15 \text{ V}, \text{ I}_{\rm D} = 5.5 \text{ A}$		24		S
Dynamic ^b	915	VDS = 10 V, 10 = 0.0 / V		24		5
Input Capacitance	C _{iss}			424		<u>г </u>
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		100		pF
		$v_{\rm DS} = 13$ v, $v_{\rm GS} = 0$ v, $t = 10012$				
Reverse Transfer Capacitance	C _{rss}	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 5.5 A		42	40	
Total Gate Charge	Qg	$v_{DS} = 15 v, v_{GS} = 10 v, I_D = 5.5 A$		8.2 4.2	13 7	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 5.5 \text{ A}$		1.4	,	
Gate-Drain Charge	Q _{gd}			1.4		
Gate Resistance	Rg	f = 1 MHz	2.5	12.6	25.2	Ω
Turn-On Delay Time	t _{d(on)}			6	12	- ns
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_1 = 3.4 \Omega$		20	30	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.4 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		14	21	
Fall Time	t _f	5		10	20	
Turn-On Delay Time	t _{d(on)}			3	6	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_1 = 3.4 \Omega$		11	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \approx 4.4 \text{ A}, V_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$		20	30	
Fall Time	t _f			7	14	
Drain-Source Body Diode Characteristic	s			I		
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			2.1	
Pulse Diode Forward Current	I _{SM}				25	A
Body Diode Voltage	V _{SD}	$I_{S} = 4.4 \text{ A}, V_{GS} = 0 \text{ V}$		0.82	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			13	20	ns
Body Diode Reverse Recovery Charge	Q _{rr}			6	12	nC
Reverse Recovery Fall Time	t _a	$I_F = 4.4 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{T}_J = 25 ^\circ\text{C}$		8		ns
Reverse Recovery Rise Time	t _b			5		

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

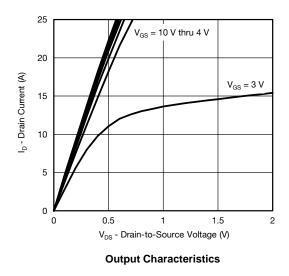
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

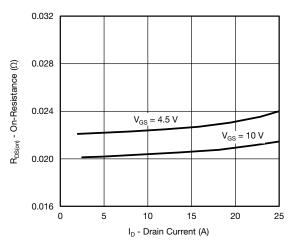
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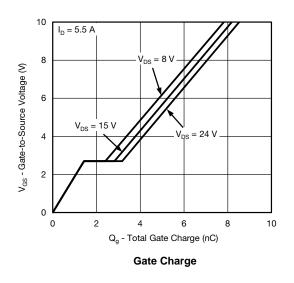


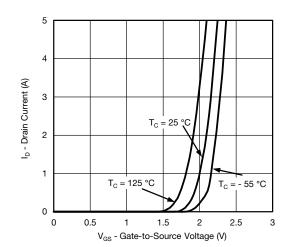
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



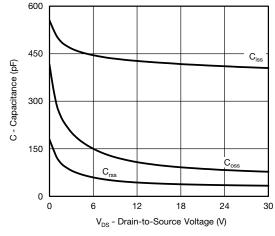


On-Resistance vs. Drain Current and Gate Voltage

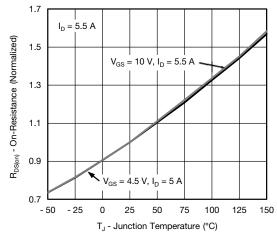




Transfer Characteristics







On-Resistance vs. Junction Temperature

10



10

1000

I_D = 5.5 A $R_{DS(on)}$ - On-Resistance (Ω) 0.045 I_s - Source Current (A) $T_{J} = 150$ T_{.1} = 125 °C 1 0.030 T_J = 25 °C T_J = 25 °C 0.015 0.1 0 0.0 0.2 0.4 0.6 0.8 1.0 1.2 8 2 4 6 V_{GS} - Gate-to-Source Voltage (V) V_{SD} - Source-to-Drain Voltage (V) Source-Drain Diode Forward Voltage On-Resistance vs. Gate-to-Source Voltage 2.0 10 1.8 8 1.6 Power (W) 6 V_{GS(th)} (V) I_D = 250 μA 1.4 4 1.2 2 T_A = 25 °C 1.0 0 - 50 - 25 0 25 50 75 100 125 150 0.01 0.1 1 10 100 T_J - Temperature (°C) Time (s) **Threshold Voltage** Single Pulse Power (Junction-to-Ambient) 100 Limited by R_{DS(on)} 10 I_D - Drain Current (A) 100 us 1 ms 1 10 ms 0.1 100 ms 10 s. 1 T_C = 25 °C Single Pulse DC TT **BVDSS** Limited 0.01

0.060

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



 V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

1

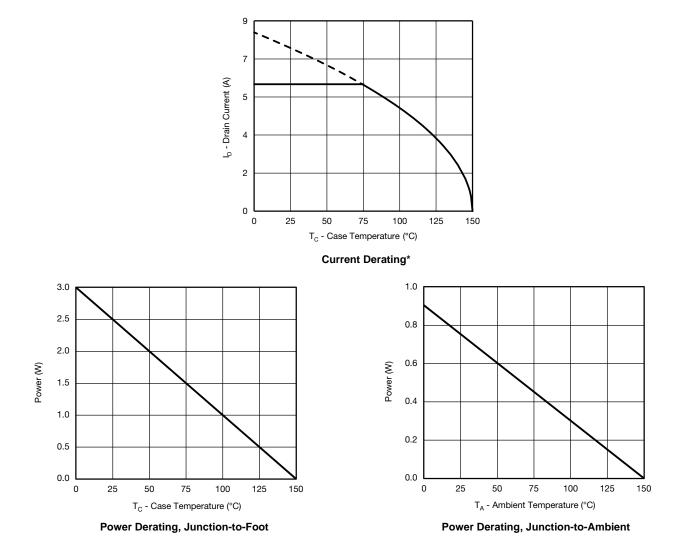
10

100

0.1



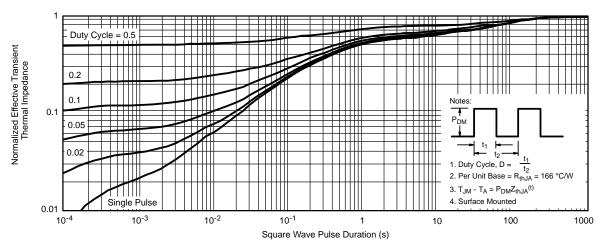
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



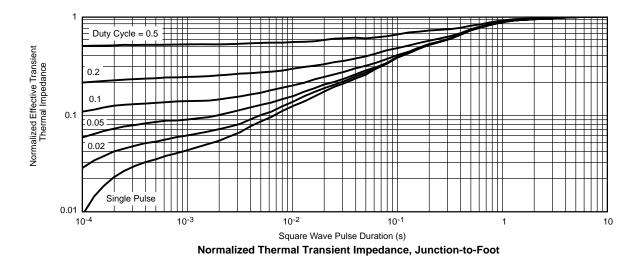
* The power dissipation P_D is based on $T_{J(max.)} = 150 \text{ °C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

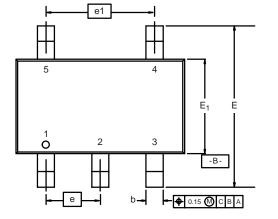


Normalized Thermal Transient Impedance, Junction-to-Ambient

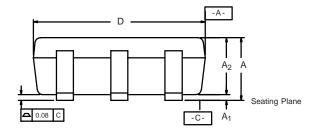


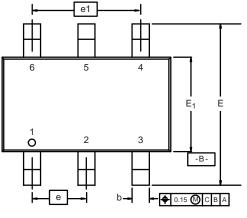


TSOP: 5/6–LEAD JEDEC Part Number: MO-193C

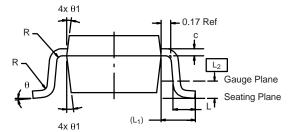








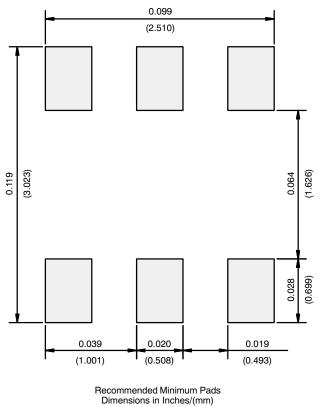
6-LEAD TSOP



	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A ₁	0.01	-	0.10	0.0004	-	0.004	
A ₂	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	2.70	2.85	2.98	0.106	0.112	0.117	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.95 BSC			0.0374 BSC			
e ₁	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L ₁	0.60 Ref			0.024 Ref			
L ₂	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
θ1	7° Nom			7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							



RECOMMENDED MINIMUM PADS FOR TSOP-6





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